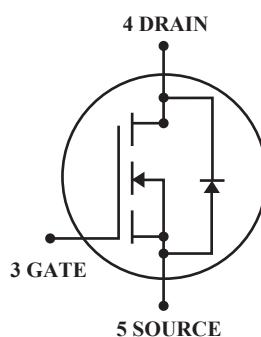
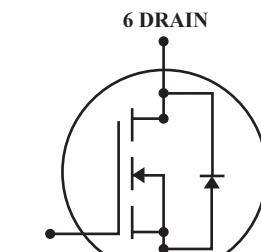


Dual N-Channel Enhancement Mode MOSFET

 **Lead(Pb)-Free**

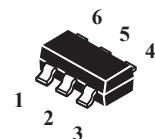
Features:

- *Super High Dense Cell Design For Low $R_{DS(ON)}$
 $R_{DS(ON)} < 80\text{m}\Omega @ V_{GS}=4.5\text{V}$
- *Rugged and Reliable
- *Capable of 2.5V Gate Drive
- *Simple Drive Requirement
- *SOT-26 Package



**DRAIN CURRENT
2.5 AMPERES**

**DRAIN SOURCE VOLTAGE
20 VOLTAGE**



SOT-26

Maximum Ratings ($T_A=25^\circ\text{C}$ Unless Otherwise Specified)

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	20	V
Gate-Source Voltage	V_{GS}	± 10	
Continuous Drain Current ¹ , $V_{GS}@4.5\text{V}$, $T_A=25^\circ\text{C}$ -Pulsed ²	I_D	2.5	A
	I_{DM}	8	
Drain-Source Diode Forward Current ¹	I_S	1.25	
Total Power Dissipation ¹ ($T_A=25^\circ\text{C}$)	P_D	1	W
Maximum Junction-ambient ¹	$R_{\theta JA}$	125	$^\circ\text{C}/\text{W}$
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55~+150	$^\circ\text{C}$

Device Marking

WTL2622=STS2622

Electrical Characteristics ($T_A = 25^\circ\text{C}$ Unless otherwise noted)

Characteristic	Symbol	Min	Typ ³	Max	Unit
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OFF Characteristics

Drain-Source Breakdown Voltage $V_{GS}=0, I_D=250\mu\text{A}$	BV_{DSS}	20	-	-	V
Drain-Source Leakage Current $V_{DS}=16\text{V}, V_{GS}=0\text{V}$	I_{DSS}	-	-	1	μA
Gate-Source Leakage current $V_{GS}=\pm 10\text{V}, V_{DS}=0\text{V}$	I_{GSS}	-	-	± 100	nA

ON Characteristics²

Gate-Source Threshold Voltage $V_{DS}=V_{GS}, I_D=250\mu\text{A}$	$V_{GS(\text{Th})}$	0.5	0.8	1.5	V
Drain-Source On-Resistance $V_{GS}=4.5\text{V}, I_D=2.5\text{A}$ $V_{GS}=2.5\text{V}, I_D=2.0\text{A}$	$R_{DS(\text{on})}$	- -	65 90	80 110	$\text{m}\Omega$
On-State Drain Current $V_{DS}=5\text{V}, V_{GS}=4.5\text{V}$	$I_{D(\text{ON})}$	6	-	-	A
Forward Transconductance $V_{DS}=5\text{V}, I_D=2.5\text{A}$	g_{fs}	-	7	-	S

Dynamic Characteristics³

Input Capacitance $V_{GS}=0\text{V}, V_{DS}=10\text{V}, f=1.0\text{MHz}$	C_{iss}	-	220	-	pF
Output Capacitance $V_{GS}=0\text{V}, V_{DS}=10\text{V}, f=1.0\text{MHz}$	C_{oss}	-	67	-	
Reverse Transfer Capacitance $V_{GS}=0\text{V}, V_{DS}=10\text{V}, f=1.0\text{MHz}$	C_{rss}	-	50	-	

Electrical Characteristics ($T_A = 25^\circ\text{C}$ Unless otherwise noted)

Characteristic	Symbol	Min	Typ ³	Max	Unit
----------------	--------	-----	------------------	-----	------

Switching Characteristics³

Turn-on Delay Time ² $V_{DS}=10\text{V}, V_{GS}=4.5\text{V}, I_D=1\text{A}, R_{GEN}=6\Omega$	$t_{d(on)}$	-	10.2	-	ns
Rise Time $V_{DS}=10\text{V}, V_{GS}=4.5\text{V}, I_D=1\text{A}, R_{GEN}=6\Omega$	t_r	-	8.3	-	
Turn-off Delay Time $V_{DS}=10\text{V}, V_{GS}=4.5\text{V}, I_D=1\text{A}, R_{GEN}=6\Omega$	$t_{d(off)}$	-	13.5	-	
Fall Time $V_{DS}=10\text{V}, V_{GS}=4.5\text{V}, I_D=1\text{A}, R_{GEN}=6\Omega$	t_f	-	12.7	-	
Total Gate Charge ² $V_{DS}=10\text{V}, V_{GS}=4.5\text{V}, I_D=2.5\text{A}$	Q_g	-	4	-	nC
Gate-Source Charge $V_{DS}=10\text{V}, V_{GS}=4.5\text{V}, I_D=2.5\text{A}$	Q_{gs}	-	1.5	-	
Gate-Source Change $V_{DS}=10\text{V}, V_{GS}=4.5\text{V}, I_D=2.5\text{A}$	Q_{gd}	-	0.7	-	

Source-Drain Diode Characteristics²

Forward On Voltage $V_{GS}=0\text{V}, I_S=1.25\text{A}$	V_{SD}	-	0.84	1.2	V
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Note: 1. Surface mounted on 1 in2 copper pad of FR4 board, $t \leq 10\text{sec}$.

2. Pulse Test : Pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

3. Guaranteed by design, not subject to production testing.

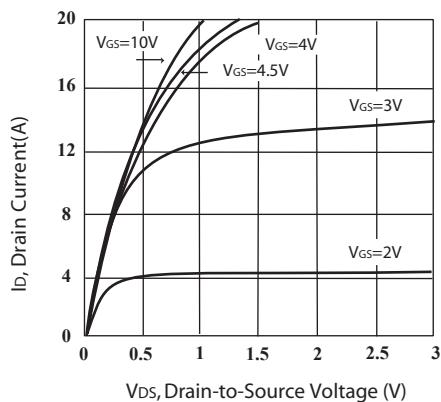


Fig.1 Output Characteristics

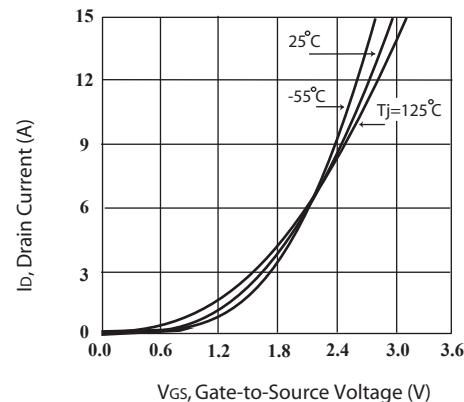


Fig.2 Transfer Characteristics

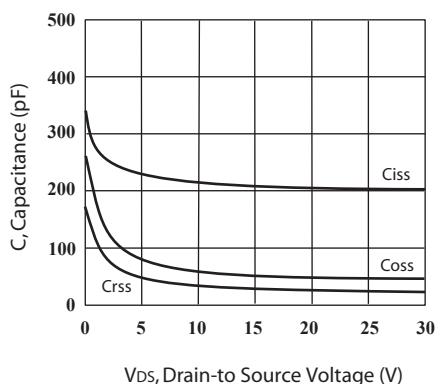


Fig.3 Capacitance with Drain to Source Voltage

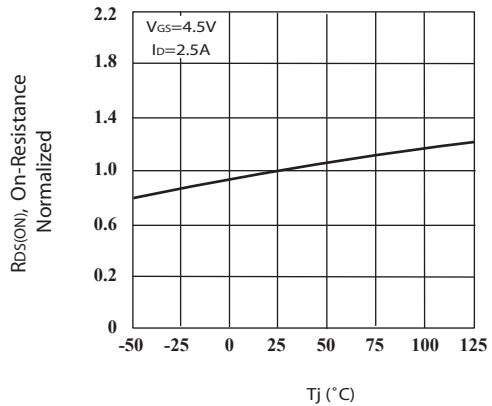


Fig.4 On-Resistance Variation with Temperature

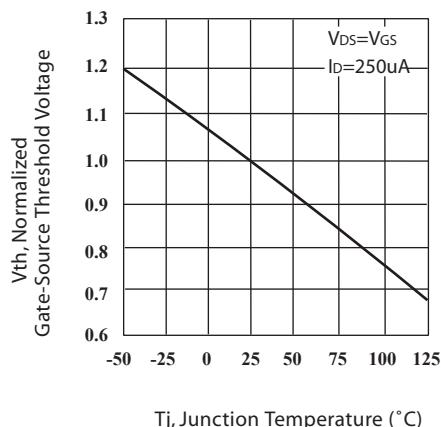


Fig.5 Gate Threshold Voltage Variation with Temperature

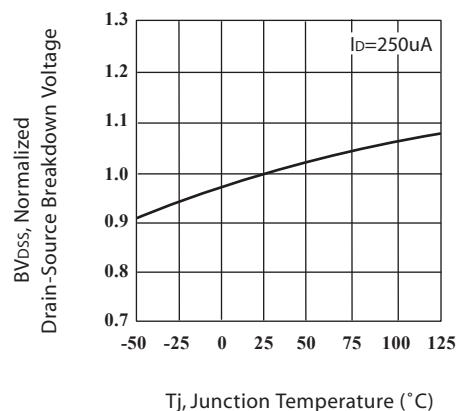


Fig.6 Breakdown Voltage Variation with Temperature

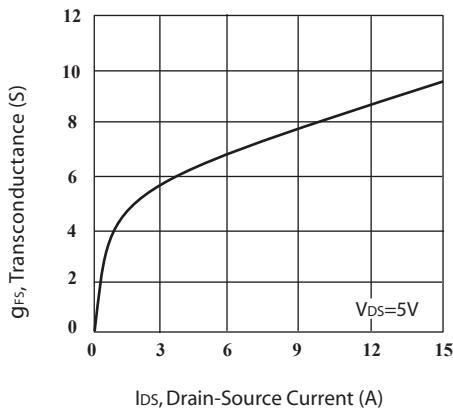


Fig.7 Transconductance Variation with Drain Current

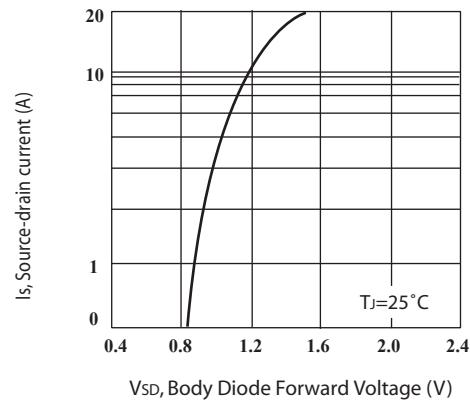


Fig.8 Body Diode Forward Voltage Variation with Source Current

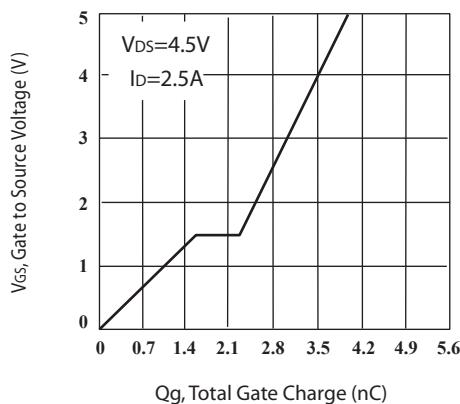


Fig.9 Gate Charge

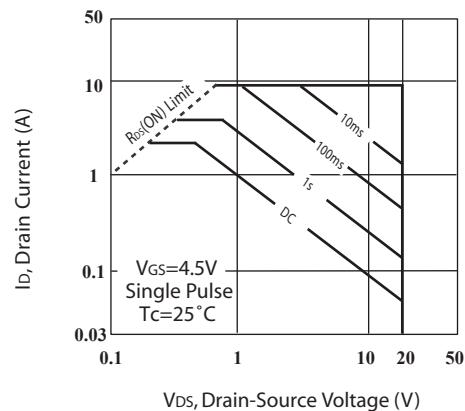


Fig.10 Maximum Safe Operating Area

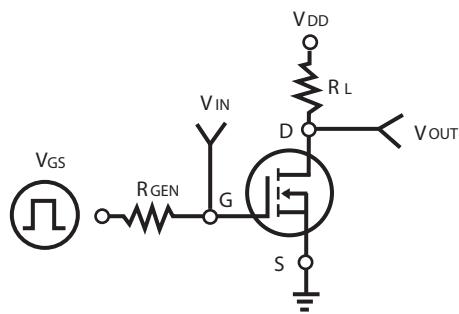


Fig.11 Switching Test Circuit

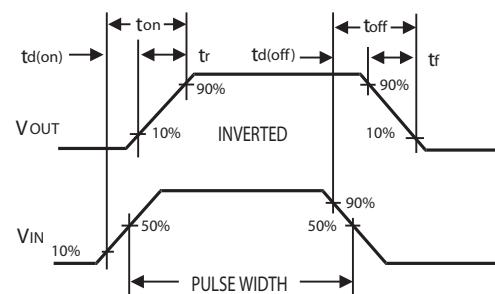
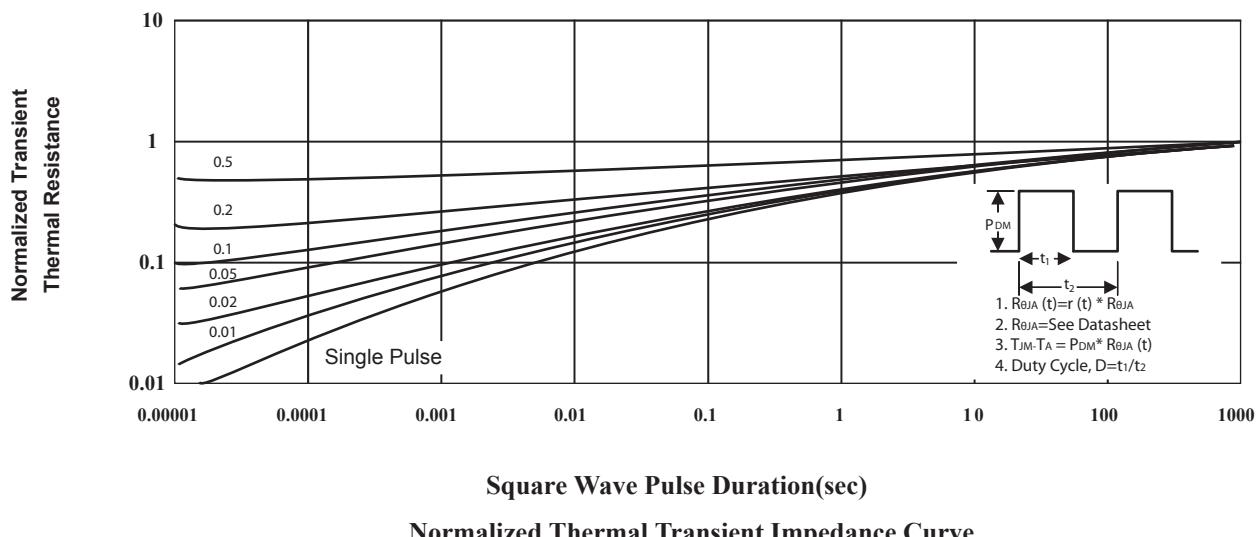
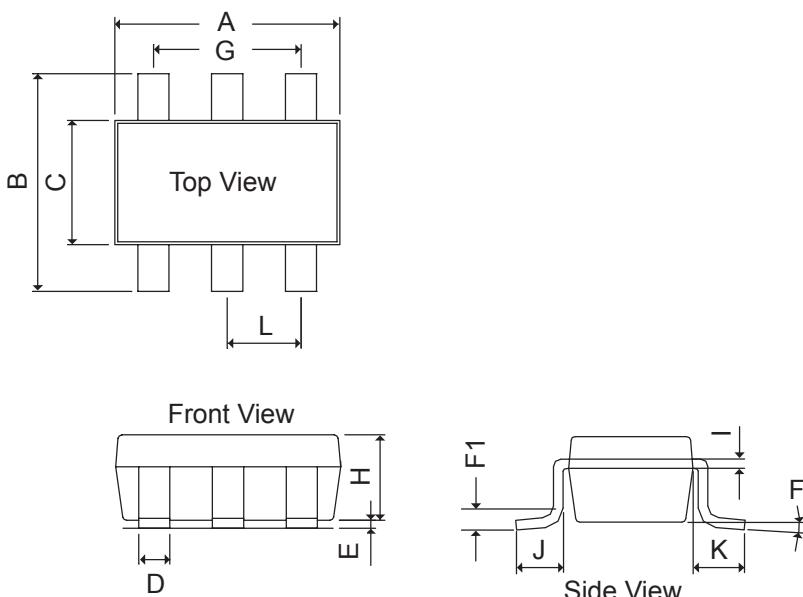


Fig.12 Switching Waveforms



SOT-26 Outline Dimension

Unit:mm



SOT-26		
Dim	Min	Max
A	2.70	3.10
B	2.60	3.00
C	1.40	1.80
D	0.30	0.55
E	0.00	0.10
F	0°	10°
F1	0.08	0.25
G	1.90 REF	
H	1.20 REF	
I	0.12 REF	
J	0.37 REF	
K	0.60 REF	
L	0.95 REF	